

150V N-Channel Enhancement Mode MOSFET

Description

The AP200N15MP uses advanced **APM-SGT₁** technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 10V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

$V_{DS} = 150V$ $I_D = 200A$

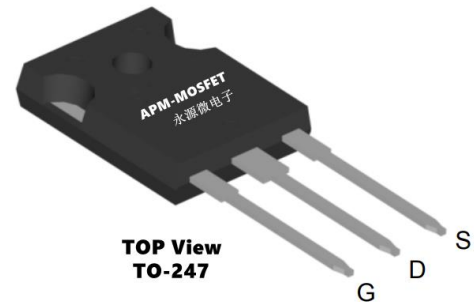
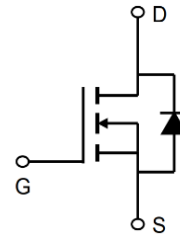
$R_{DS(ON)} < 7.2m\Omega$ @ $V_{GS} = 10V$ (Type: **6.2mΩ**)

Application

DC/DC Converter

LED Backlighting

Power Management Switches



Package Marking and Ordering Information

| Product ID | Pack | Marking | Qty(PCS) |
|------------|-----------|---------------------|----------|
| AP200N15MP | TO-247-3L | AP200N15MP XXX YYYY | 300 |

Absolute Maximum Ratings ($T_C = 25^\circ C$ unless otherwise noted)

| Symbol | Parameter | Rating | Units |
|---------------------------|--|------------|--------------|
| V_{DS} | Drain-Source Voltage | 150 | V |
| V_{GS} | Gate-Source Voltage | ± 20 | V |
| $I_D @ T_C = 25^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V$ | 200 | A |
| $I_D @ T_C = 100^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V$ | 140 | A |
| IDM | Pulsed Drain Current | 550 | A |
| EAS | Single Pulse Avalanche Energy | 506 | mJ |
| IAS | Avalanche Current | 53.4 | A |
| $P_D @ T_C = 25^\circ C$ | Total Power Dissipation ⁴ | 210 | W |
| TSTG | Storage Temperature Range | -55 to 150 | $^\circ C$ |
| T_J | Operating Junction Temperature Range | -55 to 150 | $^\circ C$ |
| $R_{\theta JA}$ | Thermal Resistance Junction-Ambient | 0.84 | $^\circ C/W$ |
| $R_{\theta JC}$ | Thermal Resistance Junction-Case | 40 | $^\circ C/W$ |



150V N-Channel Enhancement Mode MOSFET

Electrical Characteristics (T_c=25°C unless otherwise noted)

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|-----------------|---|---|------|------|------|------|
| VDSS | Drain-Source Breakdown Voltage | V _{GS} = 0V, I _D = 250μA | 150 | - | - | V |
| IGSS | Gate-body Leakage current | V _{DS} = 0V, V _{GS} = ±20V | - | - | ±100 | nA |
| IDSS | Zero Gate Voltage Drain Current T _J =25°C | V _{DS} = 100V, V _{GS} = 0V | - | - | 1 | μA |
| IDSS | Zero Gate Voltage Drain Current T _J =100°C | | - | - | 100 | |
| VGS(th) | Gate-Threshold Voltage | V _{DS} = V _{GS} , I _D = 250μA | 2.0 | 2.9 | 4.0 | V |
| RDS(on) | Drain-Source on-Resistance ² | V _{GS} = 10V, I _D = 20A | - | 6.6 | 7.5 | mΩ |
| Ciss | Input Capacitance | V _{DS} = 50V, V _{GS} = 0V, f = 1MHz | - | 5240 | - | pF |
| Coss | Output Capacitance | | - | 412 | - | |
| Crss | Reverse Transfer Capacitance | | - | 10 | - | |
| R _g | Gate Resistance | V _{GS} = 0V, V _{DS} = 0V, f = 1MHz | - | 1.7 | - | Ω |
| Q _g | Total Gate Charge | V _{GS} = 10V, V _{DS} = 50V, I _D = 20A | - | 18 | - | nC |
| Q _{gs} | Gate-Source Charge | | - | 10 | - | |
| Q _{gd} | Gate-Drain Charge | | - | 72 | - | |
| td(on) | Turn-on Delay Time | V _{GS} = 10V, V _{DS} = 50V, R _G = 3Ω, I _D = 20A | - | 22 | - | ns |
| t _r | Rise Time | | - | 115 | - | |
| td(off) | Turn-off Delay Time | | - | 44 | - | |
| t _f | Fall Time | | - | 105 | - | |
| VSD | Diode Forward Voltage ² | I _F = 20A, V _{GS} = 0V | - | - | 1.2 | V |
| IS | Continuous Source Current ^{1,5} | V _G =V _D =0V, Force Current | - | - | 190 | A |
| trr | Body Diode Reverse Recovery Time | I _F = 20A, dI/dt=100A/μs | - | 45 | - | ns |
| Q _{rr} | Body Diode Reverse Recovery Charge | | - | 12 | - | nC |

Notes:

- 1、 The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2、 The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%
- 3、 The EAS data shows Max. rating . The test condition is V_{DD}=50V, V_{GS}=10V, L=0.5mH, I_{AS}=45A
- 4、 The power dissipation is limited by 150°C junction temperature
- 5、 The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

Typical Characteristics

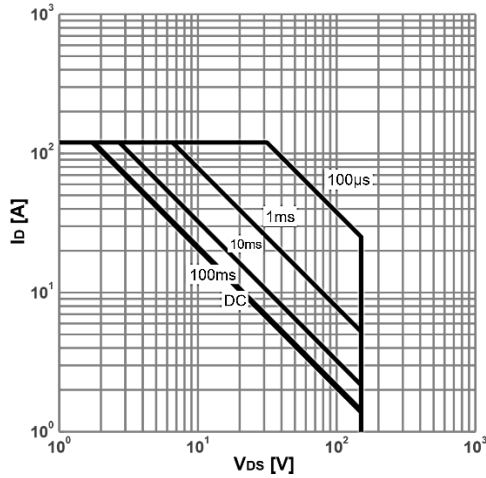


Figure 1. Power dissipation

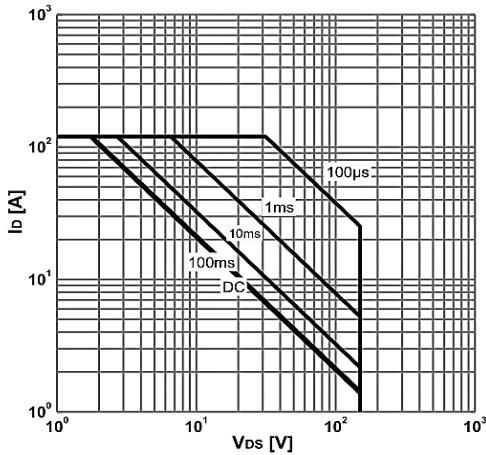


Figure 3. Safe operating area

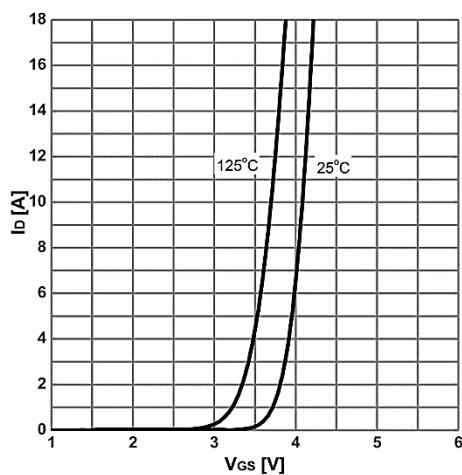


Figure 5. Typ. transfer characteristics

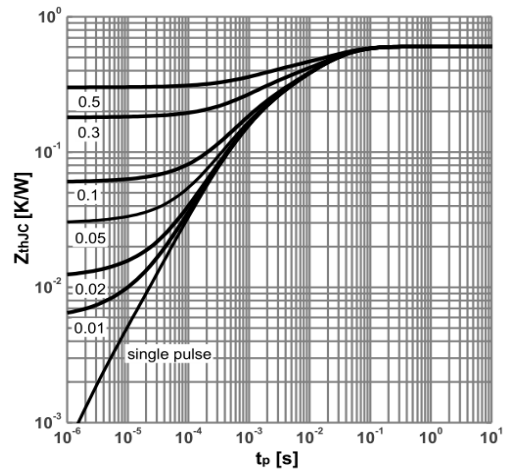


Figure 2. Max. transient thermal impedance

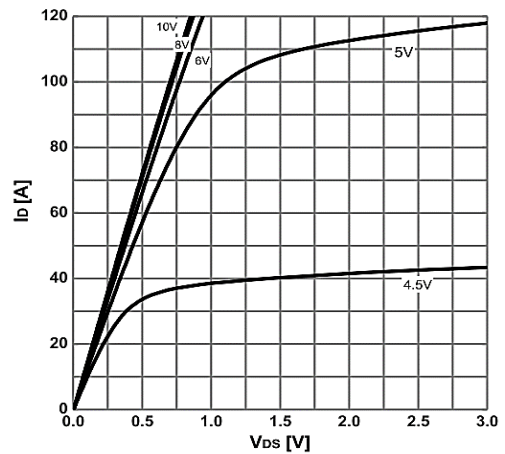


Figure 4. Typ. output characteristics

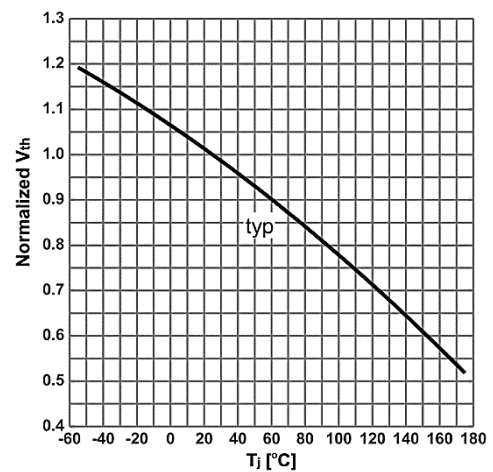


Figure 6. Gate threshold voltage vs. Junction Temperature

150V N-Channel Enhancement Mode MOSFET

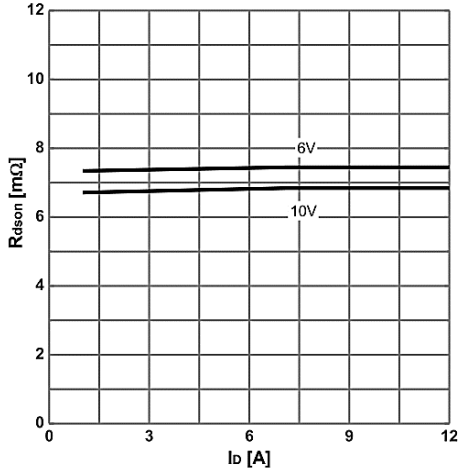


Figure 7. On-state resistance vs. Drain current

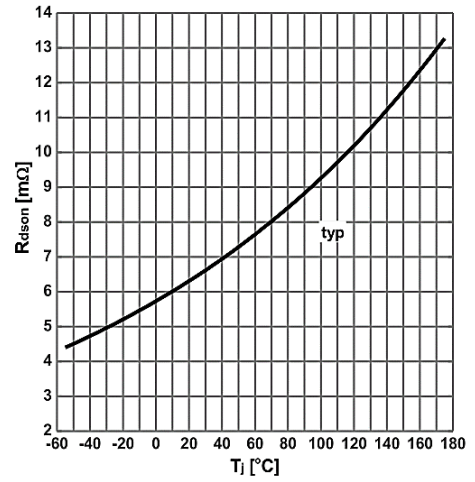


Figure 8. On-state resistance vs. Junction temperature

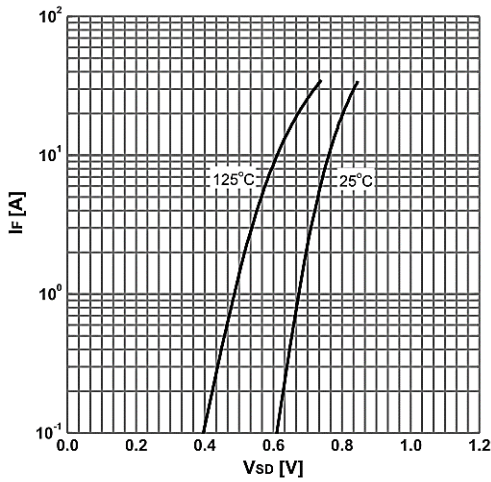


Figure 9. Forward characteristics of reverse diode

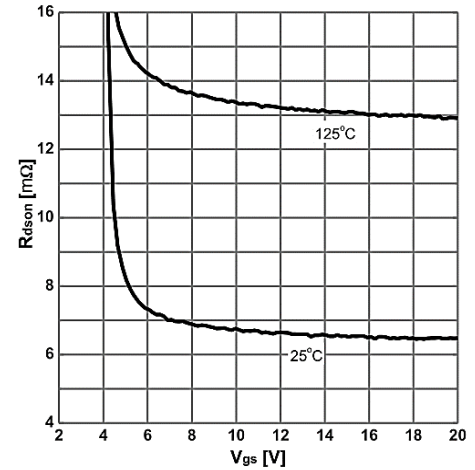


Figure 10. On-state resistance vs. Vgs characteristics

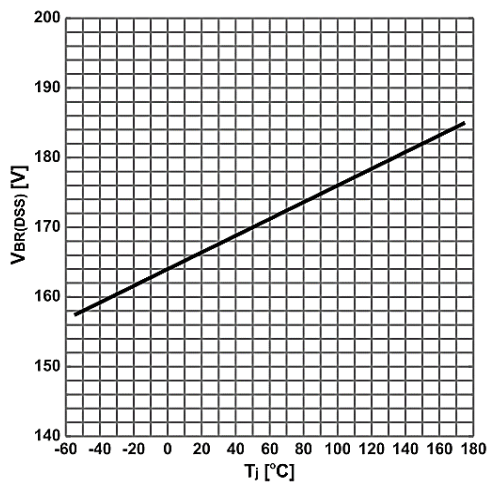


Figure 10: Breakdown Voltage Variation vs. Temperature

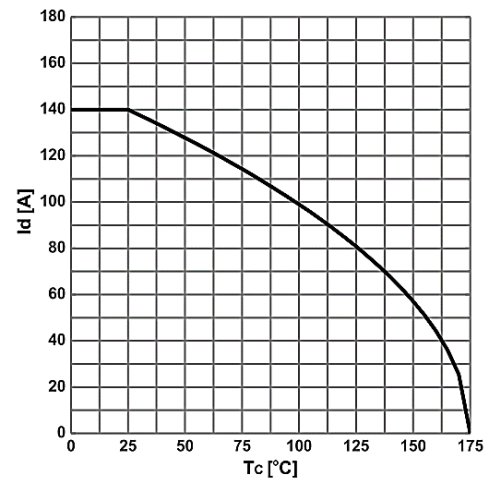
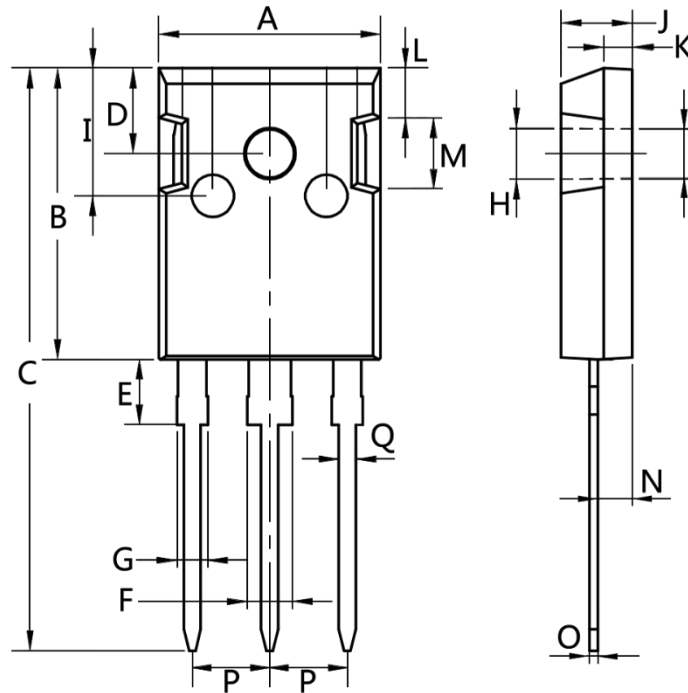


Figure 11: Maximum Drain Current

Package Mechanical Data-TO-247-3L



| Dim. | Min. | Max. |
|------|----------|------|
| A | 15.0 | 16.0 |
| B | 20.0 | 21.0 |
| C | 41.0 | 42.0 |
| D | 5.0 | 6.0 |
| E | 4.0 | 5.0 |
| F | 2.5 | 3.5 |
| G | 1.75 | 2.5 |
| H | 3.0 | 3.5 |
| I | 8.0 | 10.0 |
| J | 4.9 | 5.1 |
| K | 1.9 | 2.1 |
| L | 3.5 | 4.0 |
| M | 4.75 | 5.25 |
| N | 2.0 | 3.0 |
| O | 0.55 | 0.75 |
| P | Typ 5.08 | |
| Q | 1.2 | 1.3 |

150V N-Channel Enhancement Mode MOSFET**Attention**

1, Any and all APM Microelectronics products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your APM Microelectronics representative nearest you before using any APM Microelectronics products described or contained herein in such applications.

2, APM Microelectronics assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all APM Microelectronics products described or contained herein.

3, Specifications of any and all APM Microelectronics products described or contained here instipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.

4, APM Microelectronics Semiconductor CO., LTD. strives to supply high quality high reliability products. However, any and all semiconductor products fail with some probability. It is possible that these probabilistic failures could give rise to accidents or events that could endanger human lives that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits and error prevention circuits for safe design, redundant design, and structural design.

5, In the event that any or all APM Microelectronics products (including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from the authorities concerned in accordance with the above law.

6, No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of APM Microelectronics Semiconductor CO., LTD.

7, Information (including circuit diagrams and circuit parameters) herein is for example only; it is not guaranteed for volume production. APM Microelectronics believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.

8, Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. When designing equipment, refer to the "Delivery Specification" for the APM Microelectronics product that you intend to use.

| Edition | Date | Change |
|---------|----------|-----------------|
| Rve1.0 | 2021/8/5 | Initial release |

Copyright Attribution“APM-Microelectronice”

